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| Notice of References Cited | Application/Control No. 10/706,902 | Applicant(s)/Patent Under Reexamination CHAE ET AL. | |
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| | U | Ultraviolet from Wikipedia, http://en.wikipedia.org/wiki/Deep_ultraviolet ; 01-26-2006 |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.